

Notice of References Cited	Application/Control No. 10/756,837	Applicant(s)/Patent Under Reexamination WIERENGA ET AL.	
	Examiner Dinh Q. Nguyen	Art Unit 3752	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,056,319	05-2000	Ruckdeschel et al.	280/741
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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